

N-Channel 20V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | | |
|---------------------|----------------------------------|---------------------------------|-----------------------|--|--|--|
| V _{DS} (V) | $R_{DS(on)}(\Omega)$ | I _D (A) ^a | Q _g (Typ.) | | | |
| 20 | 0.011 at V _{GS} = 10 V | 11 | 6.1 nC | | | |
| | 0.015 at V _{GS} = 4.5 V | 9 | 6.1110 | | | |

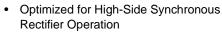
SO-8

Top View

D D

FEATURES

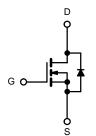
- · Halogen-free
- TrenchFET® Power MOSFET



- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

- Notebook CPU Core
 - High-Side Switch



N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS | S T _A = 25 °C, unles | s otherwise no | oted | |
|--|--|-----------------|---------------------|------|
| Parameter | Symbol | Limit | Unit | |
| Drain-Source Voltage | V_{DS} | 20 | V | |
| Gate-Source Voltage | V_{GS} | ± 16 | 7 v | |
| | T _C = 25 °C | | 11 | |
| Continuous Proin Current (T. – 150 °C) | T _C = 70 °C | | 10 | 1 |
| Continuous Drain Current (T _J = 150 °C) | T _A = 25 °C | I _D | 10 ^{b, c} | 1 |
| | T _A = 70 °C | | 8b, c | 1 |
| Pulsed Drain Current | I _{DM} | 50 | A | |
| Continuous Course Desir Die de Current | T _C = 25 °C | ı | 3.7 | 1 |
| Continuous Source-Drain Diode Current | T _A = 25 °C | I _S | 2.0 ^{b, c} | 1 |
| Single Pulse Avalanche Current | L = 0.1 mH | I _{AS} | 20 | 1 |
| Avalanche Energy | L = 0.1 IIII | E _{AS} | 21 | mJ |
| | T _C = 25 °C | | 4.1 | |
| Manianum Davian Disabation | T _C = 70 °C | В | 2.5 | W |
| Maximum Power Dissipation | T _A = 25 °C | P _D | 2.2 ^{b, c} | - vv |
| | T _A = 70 °C | | 1.3 ^{b, c} | 7 |
| Operating Junction and Storage Temperature Ra | T _J , T _{stg} | - 55 to 150 | °C | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|--------------|------------|---------|---------|--------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| Maximum Junction-to-Ambient ^{b, d} | t ≤ 10 s | R_{thJA} | 39 | 55 | °C/W | |
| Maximum Junction-to-Foot (Drain) | Steady State | R_{thJF} | 25 | 29 |] C/VV | |

Notes:

- a. Base on T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 85 °C/W.

1



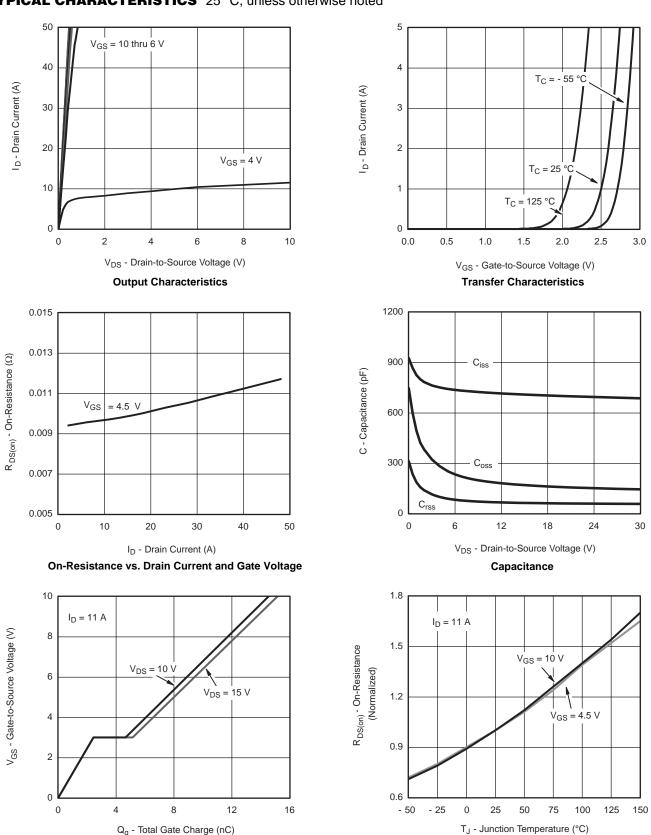
| SPECIFICATIONS $T_J = 25 ^{\circ}C$ | , unless oth | erwise noted | | | | | |
|---|---------------------------|---|------|-------|-------|-------|--|
| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | |
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | 20 | | | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | I _D = 250 μA | | 26 | | mV/°C | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_{J}$ | 1Β = 200 μΛ | | - 6 | | | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 1.0 | | 3.0 | V | |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | | | ± 100 | nA | |
| Zoro Coto Voltago Drain Current | 1 | V _{DS} = 20 V, V _{GS} = 0 V | 1 | | 1 | | |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{DS} = 20V$, $V_{GS} = 0$ V, $T_{J} = 55$ °C | | | 10 | μA | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$ | 20 | | | Α | |
| | | V _{GS} = 10V, I _D = 10 A | | 0.011 | | Ω | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | $V_{GS} = 4.5 \text{ V}, I_D = 9 \text{ A}$ | | 0.015 | | | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = 10 V, I _D = 10 A | | 50 | | S | |
| Dynamic ^b | | | | • | • | • | |
| Input Capacitance | C _{iss} | | | 800 | | pF | |
| Output Capacitance | C _{oss} | $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | | 165 | | | |
| Reverse Transfer Capacitance | C _{rss} | | | 73 | | | |
| Total Cata Charge | Qg | $V_{DS} = 10 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$ | | | 7 | nC | |
| Total Gate Charge | | | | | 6.8 | | |
| Gate-Source Charge | Q_{gs} | $V_{DS} = 10 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 10 \text{ A}$ | | | 2.5 | | |
| Gate-Drain Charge | Q_{gd} | | | | 2.3 | | |
| Gate Resistance | R_g | f = 1 MHz | 0.36 | 1.8 | 3.6 | Ω | |
| Turn-On Delay Time | t _{d(on)} | | | 16 | 23 | | |
| Rise Time | t _r | V_{DD} = 10 V, R_L = 1.4 Ω | | 12 | 16 | 1 | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong 9 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$ | | 16 | 22 | | |
| Fall Time | t _f | | | 10 | 18 | no | |
| Turn-On Delay Time | t _{d(on)} | | | 8 | 16 | ns | |
| Rise Time | t _r | V_{DD} = 10 V, R_L = 1.4 Ω | | 10 | 20 | | |
| Turn-Off Delay Time | t _{d(off)} | $I_D\cong 9$ A, $V_{GEN}=10$ V, $R_g=1$ Ω | | 16 | 22 | | |
| Fall Time | t _f | | | 8 | 15 | | |
| Drain-Source Body Diode Characterist | ics | | | | | | |
| Continuous Source-Drain Diode Current | I _S | $T_C = 25 ^{\circ}C$ | | | 11 | Δ | |
| Pulse Diode Forward Current ^a | I _{SM} | | | | 50 | | |
| Body Diode Voltage | V_{SD} | I _S = 9 A | | 0.8 | 1.2 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | | | 15 | 30 | ns | |
| Body Diode Reverse Recovery Charge | Q _{rr} | I _F = 9 A, dI/dt = 100 A/μs, T _{.I} = 25 °C | | 6 | 12 | nC | |
| Reverse Recovery Fall Time | t _a | $_{1F}$ – $_{2}$ $_{3}$ $_{4}$ $_{5}$ $_{1J}$ = 25 $_{1}$ $_{2}$ | | 8 | | | |
| everse Recovery Rise Time t _b | | | | 7 | | ns | |

- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

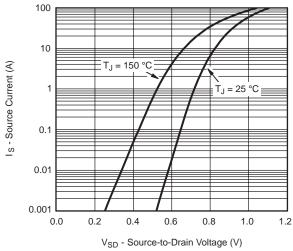


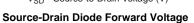
Gate Charge

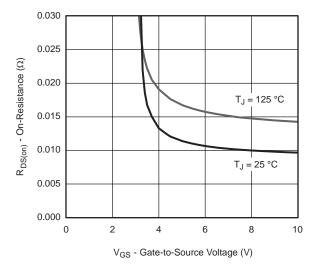


On-Resistance vs. Junction Temperature

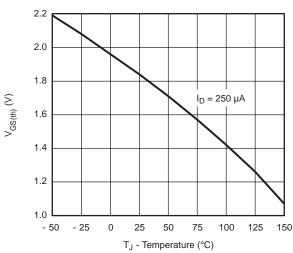




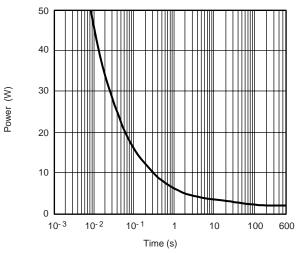




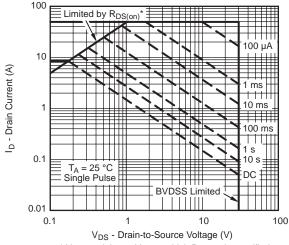
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



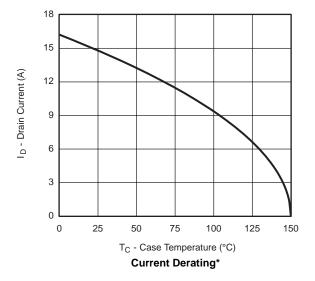
Single Pulse Power, Junction-to-Ambient

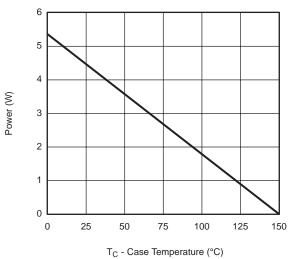


* $V_{GS} > \mbox{minimum } V_{GS}$ at which $R_{DS(on)}$ is specified

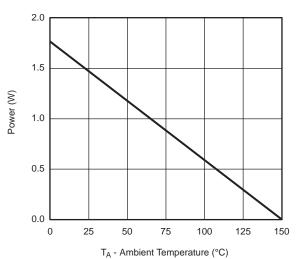
Safe Operating Area, Junction-to-Ambient







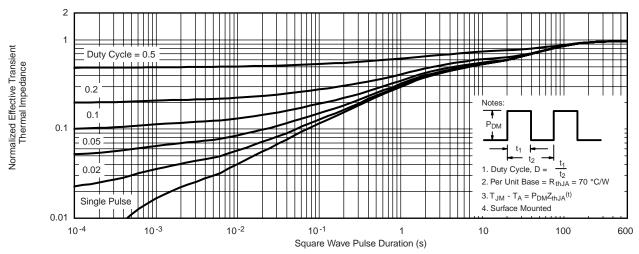
Power Derating, Junction-to-Foot



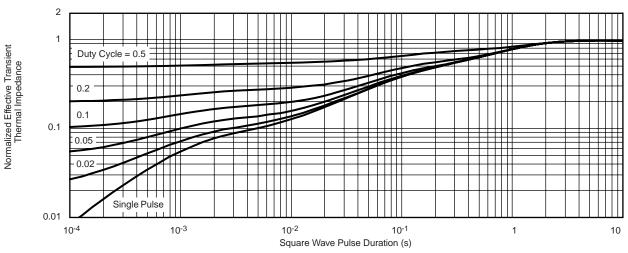
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





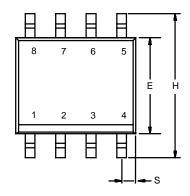
Normalized Thermal Transient Impedance, Junction-to-Ambient

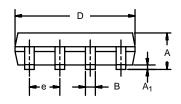


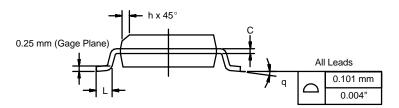
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD







| | MILLIM | IETERS | INCHES | | |
|------------------------------|----------|--------|-----------|-------|--|
| DIM | Min | Max | Min | Max | |
| Α | 1.35 | 1.75 | 0.053 | 0.069 | |
| A ₁ | 0.10 | 0.20 | 0.004 | 0.008 | |
| В | 0.35 | 0.51 | 0.014 | 0.020 | |
| С | 0.19 | 0.25 | 0.0075 | 0.010 | |
| D | 4.80 | 5.00 | 0.189 | 0.196 | |
| E | 3.80 | 4.00 | 0.150 | 0.157 | |
| е | 1.27 BSC | | 0.050 BSC | | |
| Н | 5.80 | 6.20 | 0.228 | 0.244 | |
| h | 0.25 | 0.50 | 0.010 | 0.020 | |
| L | 0.50 | 0.93 | 0.020 | 0.037 | |
| q | 0° | 8° | 0° | 8° | |
| S | 0.44 | 0.64 | 0.018 | 0.026 | |
| FCN: C-06527-Rev I 11-Sen-06 | | | | | |

ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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